MOTOROLA
SEMICONDUCTOR
TECHNICAL DATA

Designer's Data Sheet
Power Field Effect Transistor
N-Channel Enhancement-Mode
Silicon Gate TMOS

These TMOS Power FETs are designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data — I_{DSS}, $V_{DS(on)}$, $V_{GS(th)}$ and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads

MTH8N55
MTH8N60
MTM8N60

TMOS POWER FETs
8 AMPERES
$r_{DS(on)} \approx 0.5$ OHM
550 and 600 VOLTS

MTM8N60
CASE 1-06
TO-204AA

MTH8N55
MTH8N60
CASE 340-02
TO-218AC

MAXIMUM RATINGS

Rating	Symbol	MTH8N55	MTH8N60 MTM8N60	Unit
Drain-Source Voltage	V_{DSS}	550	600	Vdc
Drain-Gate Voltage (R_{GS} = 1 MΩ)	V_{DGR}	550	600	Vdc
Gate-Source Voltage Continuous Non-repetitive ($t_p \leq 50~\mu s$)	V_{GS} V_{GSM}		±20 ±40	Vdc Vpk
Drain Current — Continuous — Pulsed	I_D I_{DM}		8 41	Adc
Total Power Dissipation @ T_C = 25°C Derate above 25°C	P_D		150 1.2.	Watts W/°C
Operating and Storage Temperature Range	T_J, T_{stg}		−65 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case — Junction to Ambient	$R_{\theta JC}$ $R_{\theta JA}$	0.83 30	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T_L	275	°C

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Drain-Source Breakdown Voltage (V_{GS} = 0, I_D = 0.25 mA) MTH8N55 MTH8N60, MTM8N60	$V_{(BR)DSS}$	550 600	— —	Vdc
Zero Gate Voltage Drain Current (V_{DS} = Rated V_{DSS}, V_{GS} = 0) (V_{DS} = 0.8 Rated V_{DSS}, V_{GS} = 0, T_J = 125°C)	I_{DSS}	— —	0.2 1	mAdc

(continued)

MOTOROLA TMOS POWER MOSFET DATA

ELECTRICAL CHARACTERISTICS — continued (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS					
Gate-Body Leakage Current, Forward (V_{GSF} = 20 Vdc, V_{DS} = 0)		I_{GSSF}	—	100	nAdc
Gate-Body Leakage Current, Reverse (V_{GSR} = 20 Vdc, V_{DS} = 0)		I_{GSSR}	—	100	nAdc
ON CHARACTERISTICS*					
Gate Threshold Voltage (V_{DS} = V_{GS}, I_D = 1 mA) T_J = 100°C		$V_{GS(th)}$	2 1.5	4.5 4	Vdc
Static Drain-Source On-Resistance (V_{GS} = 10 Vdc, I_D = 4 Adc)		$r_{DS(on)}$	—	0.5	Ohm
Drain-Source On-Voltage (V_{GS} = 10 V) (I_D = 8 Adc) (I_D = 4 Adc, T_J = 100°C)		$V_{DS(on)}$	— —	5 4	Vdc
Forward Transconductance (V_{DS} = 10 V, I_D = 4 A)		g_{FS}	4	—	mhos
DYNAMIC CHARACTERISTICS					
Input Capacitance	(V_{DS} = 25 V, V_{GS} = 0, f = 1 MHz) See Figure 11	C_{iss}	—	2300	pF
Output Capacitance		C_{oss}	—	425	
Reverse Transfer Capacitance		C_{rss}	—	180	
SWITCHING CHARACTERISTICS* (T_J = 100°C)					
Turn-On Delay Time	(V_{DD} = 25 V, I_D = 0.5 Rated I_D R_{gen} = 50 ohms) See Figures 13 and 14	$t_{d(on)}$	—	70	ns
Rise Time		t_r	—	160	
Turn-Off Delay Time		$t_{d(off)}$	—	430	
Fall Time		t_f	—	200	
Total Gate Charge	(V_{DS} = 0.8 Rated V_{DSS}, I_D = Rated I_D, V_{GS} = 10 V) See Figure 12	Q_g	127 (Typ)	150	nC
Gate-Source Charge		Q_{gs}	62 (Typ)	—	
Gate-Drain Charge		Q_{gd}	65 (Typ)	—	
SOURCE DRAIN DIODE CHARACTERISTICS*					
Forward On-Voltage	(I_S = Rated I_D V_{GS} = 0)	V_{SD}	1.2 (Typ)	2	Vdc
Forward Turn-On Time		t_{on}	Limited by stray inductance		
Reverse Recovery Time		t_{rr}	500 (Typ)	—	ns
INTERNAL PACKAGE INDUCTANCE (TO-204)					
Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die)		L_d	5 (Typ)	—	nH
Internal Source Inductance (Measured from the source pin, 0.25" from the package to the source bond pad)		L_s	12.5 (Typ)	—	
INTERNAL PACKAGE INDUCTANCE (TO-218)					
Internal Drain Inductance (Measured from screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)		L_d	4 (Typ) 5 (Typ)	— —	nH
Internal Source Inductance (Measured from the source lead 0.25" from package to center of die)		L_s	10 (Typ)	—	

*Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

MTH8N55, MTH/MTM8N60

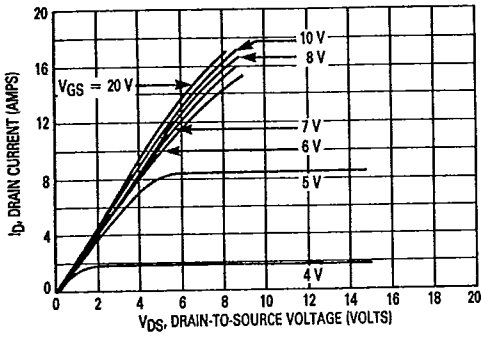## TYPICAL ELECTRICAL CHARACTERISTICS
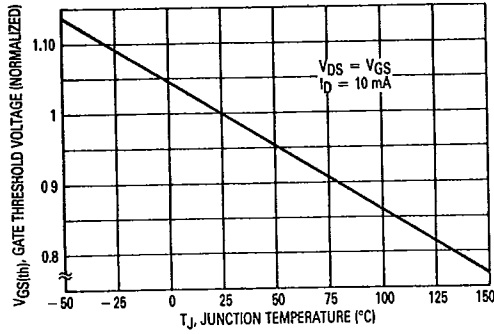

Figure 1. On-Region Characteristics

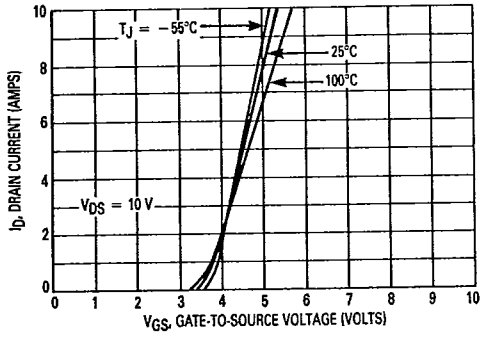Figure 2. Gate-Threshold Voltage Variation
With Temperature

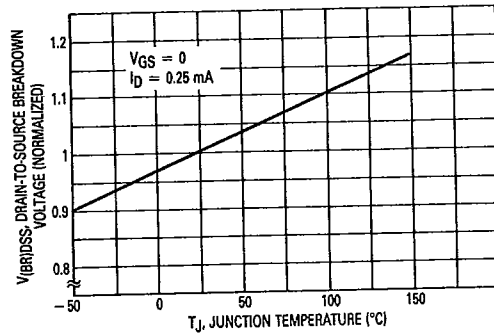Figure 3. Transfer Characteristics

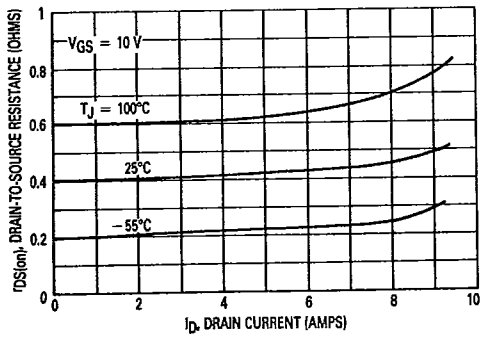Figure 4. Breakdown Voltage Variation
With Temperature

Figure 5. On-Resistance versus Drain Current

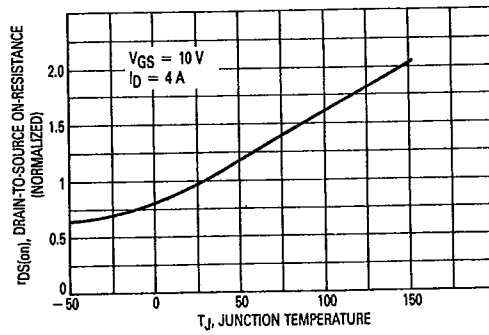Figure 6. On-Resistance Variation
With Temperature

MOTOROLA TMOS POWER MOSFET DATA

MTH8N55, MTH/MTM8N60
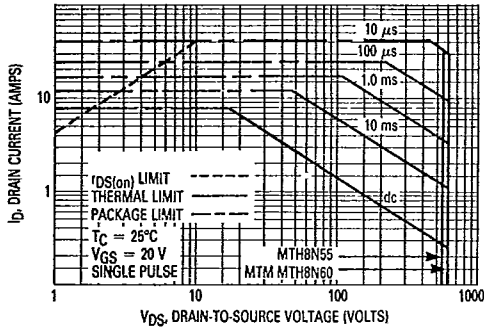
SAFE OPERATING AREA INFORMATION

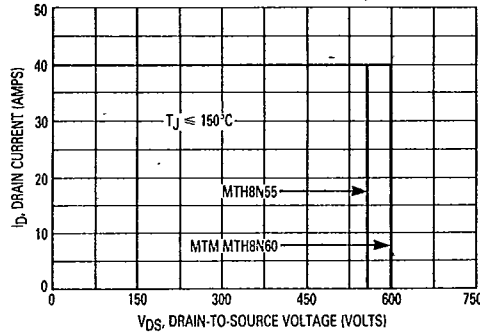**Figure 7. Maximum Rated Forward Biased Safe Operating Area**

Figure 8. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:
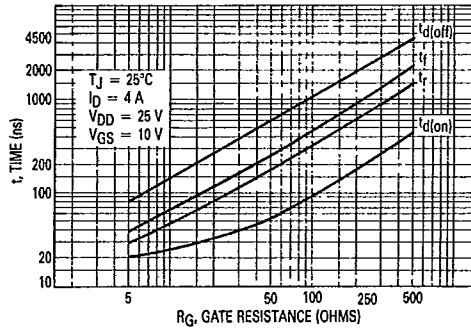
$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

Figure 9. Resistive Switching Time Variation With Gate Resistance
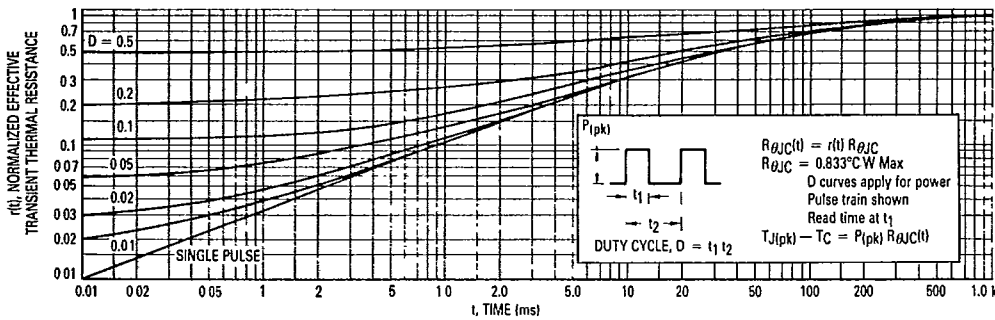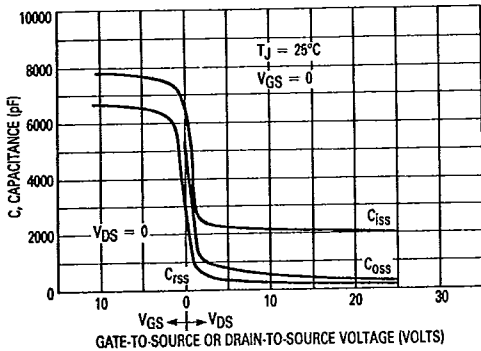

Figure 10. Thermal Response
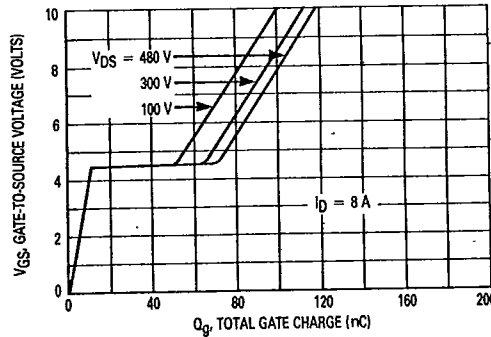
Figure 11. Capacitance Variation

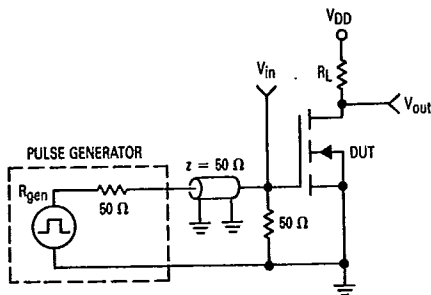Figure 12. Gate Charge versus Gate-to-Source Voltage

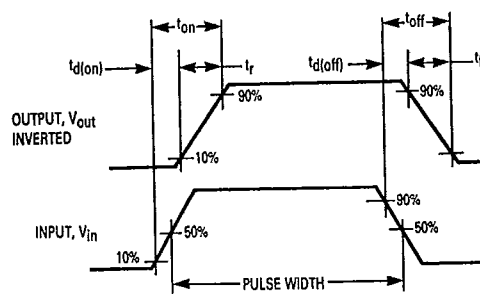## RESISTIVE SWITCHING

Figure 13. Switching Test Circuit

Figure 14. Switching Waveforms

OUTLINE DIMENSIONS

CASE 1-06
TO-204AA

DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	—	39.37	—	1.550
B	—	21.08	—	0.830
C	6.35	8.25	0.250	0.325
D	0.97	1.09	0.038	0.043
E	1.40	1.77	0.055	0.070
F	30.15 BSC		1.187 BSC	
G	13.92 BSC		0.430 BSC	
H	5.46 BSC		0.215 BSC	
J	16.89 BSC		0.665 BSC	
K	11.18	12.19	0.440	0.480
Q	3.84	4.19	0.151	0.165
R	—	26.67	—	1.050
U	4.83	5.33	0.190	0.210
V	3.84	4.19	0.151	0.165

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

STYLE 3:
PIN 1. GATE
2. SOURCE
CASE DRAIN

DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	20.32	21.08	0.800	0.830
B	15.49	15.90	0.610	0.626
C	4.19	5.08	0.165	0.200
D	1.02	1.65	0.040	0.065
E	1.35	1.65	0.053	0.065
G	5.21	5.72	0.205	0.225
H	2.65	2.94	0.104	0.116
J	0.38	0.64	0.015	0.025
K	12.70	15.49	0.500	0.610
L	15.88	16.51	0.625	0.650
N	12.19	12.70	0.480	0.500
Q	4.04	4.22	0.159	0.166

STYLE 2.
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

CASE 340-02
TO-218AC